

P-Channel Enhancement Mode Power MOSFET

Description

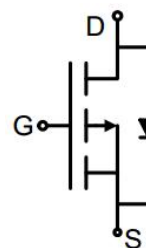
The G120P06T uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge. It can be used in a wide variety of applications.

General Features

- V_{DS} -60V
- I_D (at $V_{GS} = -10V$) -120A
- $R_{DS(ON)}$ (at $V_{GS} = -10V$) < 8.5m Ω
- 100% Avalanche Tested
- RoHS Compliant

Application

- Power switch
- DC/DC converters



Schematic diagram



TO-220

Ordering Information

Device	Package	Marking	Packaging
G120P06T	TO-220	G120P06	50pcs/Tube

Absolute Maximum Ratings $T_C = 25^\circ\text{C}$, unless otherwise noted

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	-60	V
Continuous Drain Current	I_D	-120	A
Pulsed Drain Current (note1)	I_{DM}	-480	A
Gate-Source Voltage	V_{GS}	± 20	V
Power Dissipation	P_D	277	W
Single pulse avalanche energy (note2)	E_{AS}	650	mJ
Operating Junction and Storage Temperature Range	T_J, T_{stg}	-55 To 150	$^\circ\text{C}$

Thermal Resistance

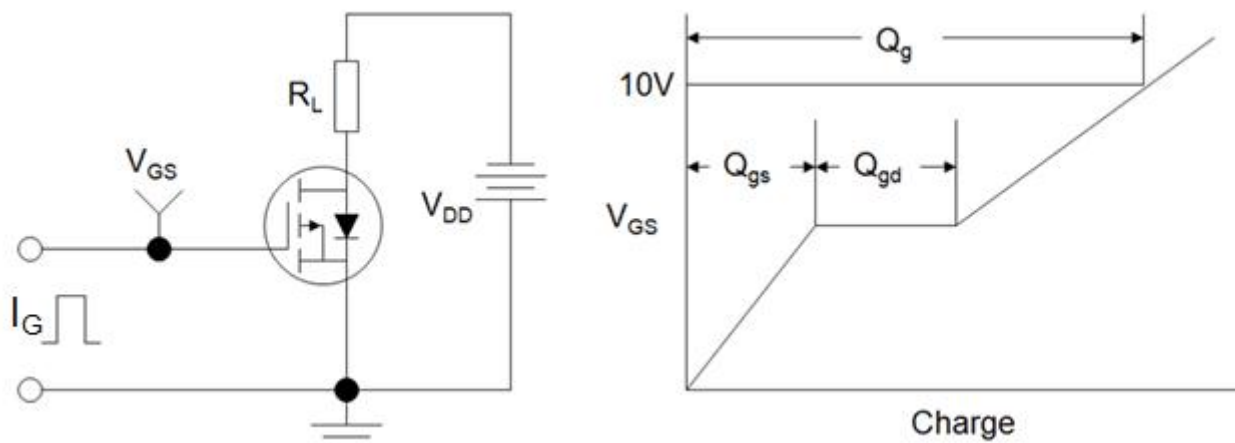
Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Ambient	R_{thJA}	65	$^\circ\text{C/W}$
Maximum Junction-to-Case	R_{thJC}	0.45	$^\circ\text{C/W}$

Specifications T _J = 25°C, unless otherwise noted						
Parameter	Symbol	Test Conditions	Value			Unit
			Min.	Typ.	Max.	
Static Parameters						
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = -250μA	-60	--	--	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = -60V, V _{GS} = 0V	--	--	-1	μA
Gate-Source Leakage	I _{GSS}	V _{GS} = ±20V	--	--	±100	nA
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = -250μA	-1	-2.5	-3	V
Drain-Source On-Resistance	R _{DS(on)}	V _{GS} = -10V, I _D = -20A	--	7	8.5	mΩ
Forward Transconductance	g _{FS}	V _{DS} = -5V,I _D = -20A	--	35	--	S
Dynamic Parameters						
Input Capacitance	C _{iss}	V _{GS} = 0V, V _{DS} = -30V, f = 1.0MHz	--	12674	--	pF
Output Capacitance	C _{oss}		--	935	--	
Reverse Transfer Capacitance	C _{rss}		--	671	--	
Total Gate Charge	Q _g	V _{DD} = -30V, I _D = -60A, V _{GS} = -10V	--	230	--	nC
Gate-Source Charge	Q _{gs}		--	50	--	
Gate-Drain Charge	Q _{gd}		--	35	--	
Turn-on Delay Time	t _{d(on)}	V _{DD} = -30V, I _D = -60A, R _G = 1Ω	--	20	--	ns
Turn-on Rise Time	t _r		--	25	--	
Turn-off Delay Time	t _{d(off)}		--	110	--	
Turn-off Fall Time	t _f		--	50	--	
Drain-Source Body Diode Characteristics						
Continuous Body Diode Current	I _S	T _C = 25°C	--	--	-60	A
Body Diode Voltage	V _{SD}	T _J = 25°C, I _{SD} = -20A, V _{GS} = 0V	--	--	-1.2	V
Reverse Recovery Charge	Q _{rr}	I _F = -30A, V _{GS} = 0V di/dt=-100A/us	--	0.21	--	nC
Reverse Recovery Time	T _{rr}		--	91	--	ns

Notes

1. Repetitive Rating: Pulse width limited by maximum junction temperature
2. EAS condition : $T_J = 25^\circ\text{C}$, $V_{DD} = -50V$, $V_{GS} = -10V$, $L = 0.5mH$, $R_g = 25\Omega$

Gate Charge Test Circuit



Switch Time Test Circuit



EAS Test Circuit



Typical Characteristics $T_J = 25^\circ\text{C}$, unless otherwise noted

Figure 1. Output Characteristics

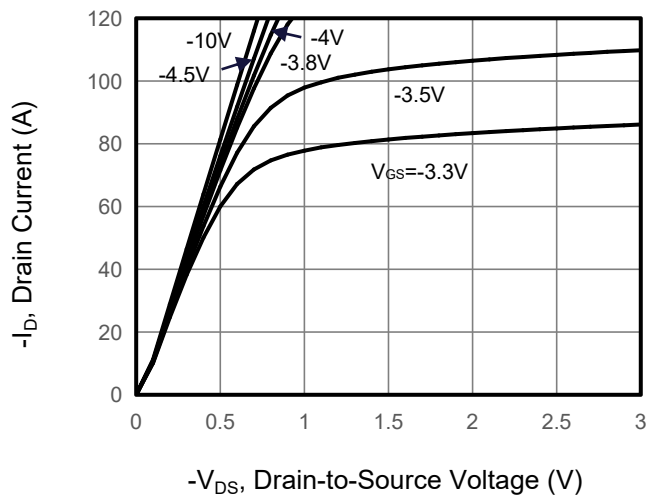


Figure 2. Transfer Characteristics

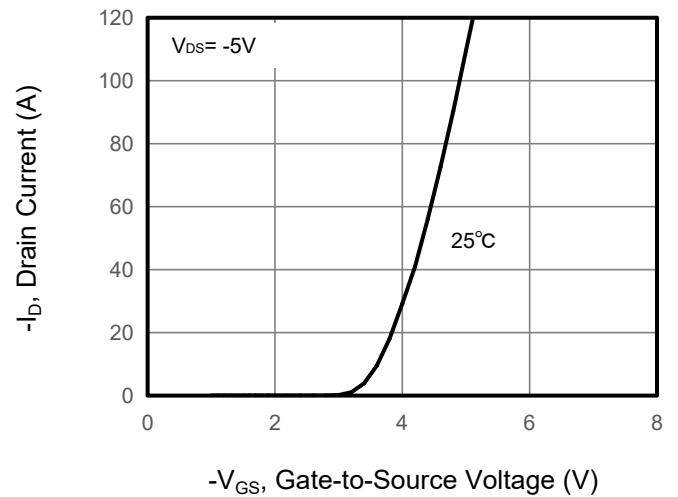


Figure 3. Drain Source On Resistance

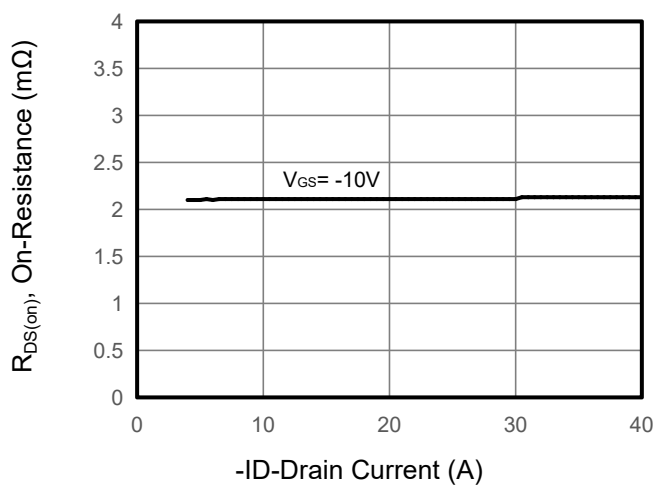


Figure 4. Gate Charge

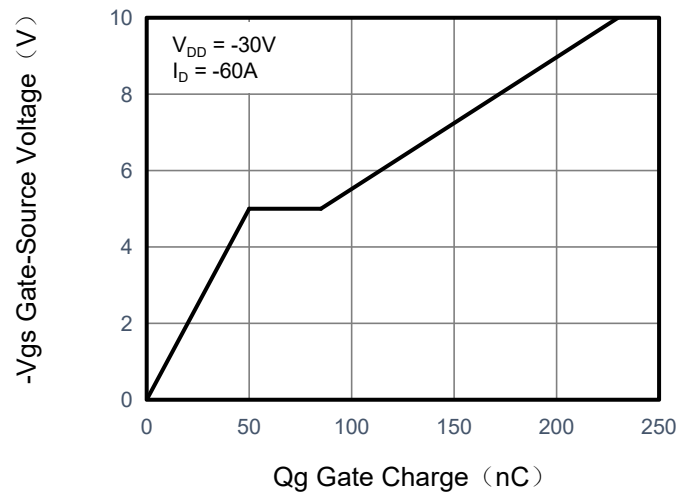


Figure 5. Capacitance

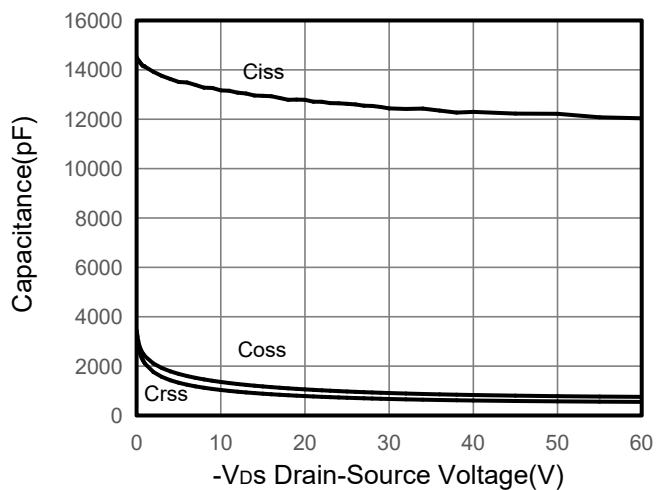
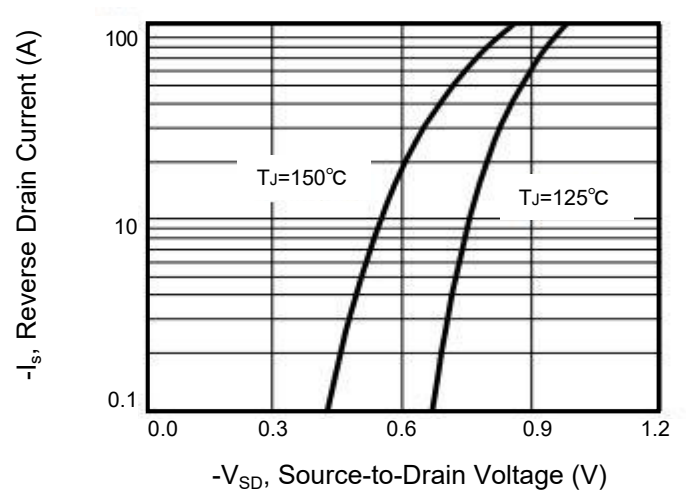


Figure 6. Source-Drain Diode Forward



Typical Characteristics $T_J = 25^\circ\text{C}$, unless otherwise noted

Figure 7. Drain-Source On-Resistance

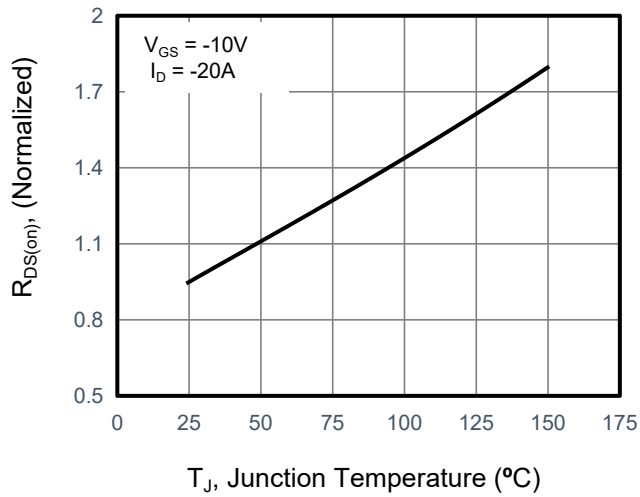


Figure 10. Safe Operation Area

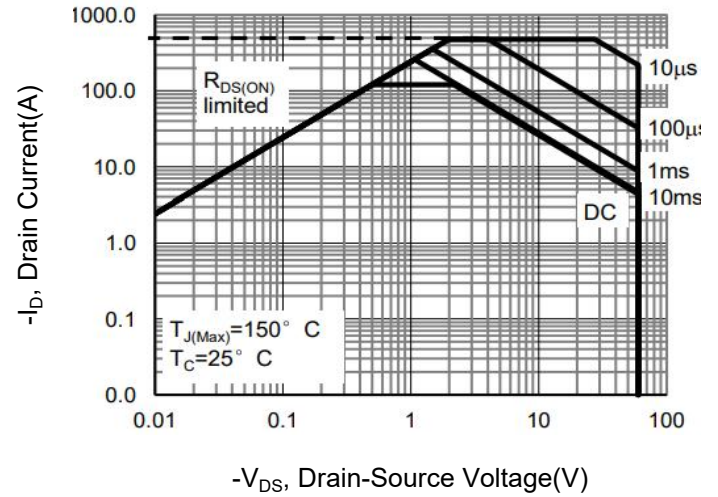
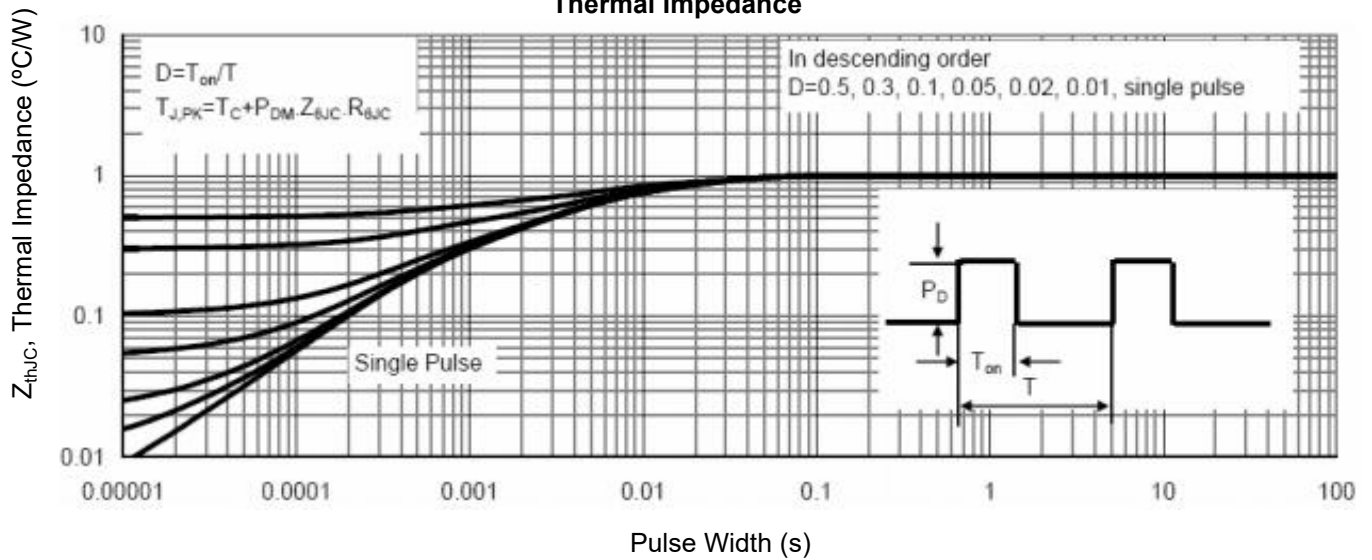
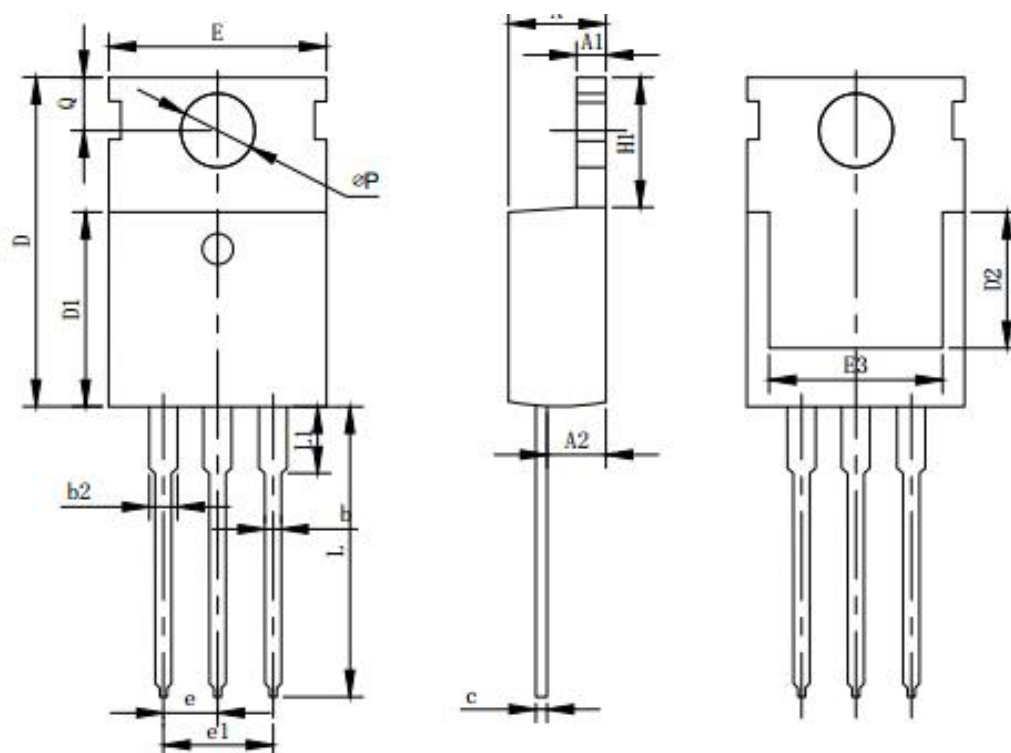


Figure 9. Normalized Maximum Transient Thermal Impedance



TO-220 Package Information



Symbol	Dimensions in Millimeters		
	MIN.	NOM.	MAX.
A	4.37	4.57	4.7
A1	1.25	1.3	1.4
A2	2.2	2.4	2.6
b	0.7	0.8	0.95
b2	1.7	1.27	1.47
c	0.45	0.5	0.6
D	15.1	15.6	16.1
D1	8.8	9.1	9.4
D2	5.5		
E	9.7	10	10.3
e	2.54BSC		
e1	5.08BSC		
H1	6.25	6.5	6.85
L	12.75	13.5	13.8
L1		3.1	3.4
∅ P	3.4	3.6	3.8
Q	2.6	2.8	3